

# **Test report**

Number: T251-0xxx/17 Project file: C20171221

Date: 2017-06-22

Pages: 49

Product: Nucleo expansion board

Type reference: X-NUCLEO-NFC05A1

Ratings: USB: 5 VDC 5%/500 mA;

Operating clock frequency: 13.56 MHz

Protection class: III

Trademark: STMicroelectronics Austria GmbH

Applicant: STMicroelectronics Austria GmbH

Kratkystrasse 2, AT-8020 Graz, Austria

Manufacturer: ASTRON Electronic GmbH

Feistritz 333, AT-9613 Feistritz an der Gail, Austria

Place of manufacture: ASTRON Electronic GmbH

Feistritz 333, AT-9613 Feistritz an der Gail, Austria

**Summary of testing** 

Testing method: FCC 47 CFR Part 15, Subpart C

RSS-210 Issue 9 (Annex B.6)

RSS-Gen issue 4 (clause 6.6 and tables 3,4,5 and 6)

Testing location: SIQ Ljubljana, Trpinčeva ulica 37 A, SI-1000 Ljubljana, Slovenia

Remarks: Date of receipt of test items: 2017-04-04

Number of items tested: 2

Date of performance of tests: 2017-04-25 - 2017-05-23

The test results presented in this report relate only to the items tested. The product complies with the requirements of the testing methods.

/

Tested by: Andrej Škof Approved by: Marjan Mak

The report shall not be reproduced except in full.

# T251-0xxx/17

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# 1 GENERAL

History sheet					
Date	Report No.	Change	Revision		
2017-06-22	T251-0xxx/17	Initial Test Report issued.			

#### **Environmental conditions:**

Ambient temperature: 15°C to 35°C Relative humidity: 30% to 60%

Atmospheric pressure: 860 mbar to 1060 mbar

# 1.1 Equipment under test

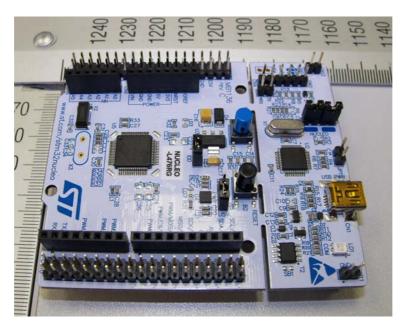
Nucleo expansion board Type: X-NUCLEO-NFC05A1 FCC ID: YCPNFC05A1

Tested SIQ sample number: S20172501 (original sample)

S20173104 (sample with dummy load)

#### **Pictures of EUT:**





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# 1.1.1 General product information

Product	Reader Board HF NFC
Type / Model	ST25R3911B-DISCO
Supply voltage of transmitter	5 VDC via USB
Operating frequency	13,56 MHz (NFC tag)
Antenna type	PCB, 47 mm x 34 mm, four turns
Modulation type:	ISO14443A, ISO14443B, ISO15693 and FeliCa™
Hardware version:	NFC05A1
Software version:	X-CUBE-NFC5 V1.0.0
Card reading/Writing distance	From 0 to 40mm with CLOUD-ST25TA tag

# 1.1.2 Auxiliary equipment used during testing

- NUCLEO-L476RG mother board
- Laptop: Lenovo ThinkPad L560



# 2 TEST SUMMARY

STANDARD		Tested		mple
	yes	no	pass	not pass
FCC 47 CFR Part 15, Subpart C (§2.202, §15.203, §15.205, §15.207, §15.209, §15.215, §15.225 (a-d), §15.225 (e))  RSS-210 Issue 9 (Annex B.6)	Ø		Ø	
RSS-Gen issue 4 (clause 6.6 and tables 3,4,5 and 6)				

Clause (FCC 47 CFR Part 15)	Clause (RSS-Gen issue 4)	Clause (RSS-210 issue 9)	Test description	Section within the report	Conclusion
§2.202	6.6		Occupied bandwidth	4.1	PASS
§15.203			Antenna requirements	4.2	PASS
§15.205	Table 6		Restricted bands of operation	4.3	PASS
§15.207	Table 3		Conducted emission	4.4	PASS
§15.209	Table 4 and 5		Radiated emission – general requirements	4.5	PASS
§15.215			20 dB Bandwidth	4.6	PASS
§15.225 (a-d)		Annex B.6	Operation within the band 13.110- 14.010 MHz	4.7	PASS
§15.225 (e)			Carrier Frequency stability	4.8	PASS

# 2.1 Operating voltages/frequencies used for testing

Clause (FCC 47 CFR Part 15)	Clause (RSS-Gen issue 4)	Clause (RSS-210 issue 9)	Test description	Operating conditions
§2.202	6.6		Occupied bandwidth	5 VDC via USB
§15.203			Antenna requirements	1
§15.205	Table 6		Restricted bands of operation	5 VDC via USB
§15.207	Table 3		Conducted emission	5 VDC via USB
§15.209	Table 4 and 5		Radiated emission – general requirements	5 VDC via USB
§15.215			20 dB Bandwidth	5 VDC via USB
§15.225 (a-d)		Annex B.6	Operation within the band 13.110-14.010 MHz	5 VDC via USB
§15.225 (e)		_	Carrier Frequency stability	4.25 VDC - 5.75 VDC

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# 3 CONVERSION FACTORS AND ALL OTHER FORMULAS

Unit	Conversion unit	Formula of conversion
dΒμV	dBμV/m	$dB\mu V/m = dB\mu V + AF$
μV/m	dBμV/m	$dB\mu V/m = 20log(X(\mu V/m)/1\mu V)$

Test distance stated in standard	Test distance of measurement	Conversion factor
3 m	3 m	1
10 m	3 m	20dB/decade (over 30 MHz)
10 111	3111	40dB/decade (under 30 MHz)



#### 4 EMISSION TESTS

# 4.1 Occupied bandwidth (§2.202 of FCC 47 CRF 15 and clause 6.6 of RSS-Gen Issue 4)

#### Requirement §2.202

The frequency bandwidth such that, below its lower and above its upper frequency limits, the mean powers radiated are each equal to 0.5 percent of the total mean power radiated by a given emission. In some cases, for example multichannel frequency-division systems, the percentage of 0.5 percent may lead to certain difficulties in the practical application of the definitions of occupied and necessary bandwidth; in such cases a different percentage may prove useful.

The occupied bandwidth according to ANSI C63.10 is measured as the frequency range defined by the points that are 26 dB down relative to the maximum level of the modulated carrier. The resolution bandwidth of the spectrum analyzer shall be set to a value greater than 5.0% of the allowed bandwidth. If no bandwidth specifications are given, the following guidelines are used:

Fundamental frequency	Minimum resolution bandwidth
9 kHz to 30 MHz	1 kHz
30 MHz to 1000 MHz	10 kHz
1000 MHz to 40 GHz	100 kHz

The video bandwidth shall be at least three times greater than the resolution bandwidth.

#### Conclusion:

PASS; Occupied bandwidth is 2,26 kHz

#### Requirement RSS-Gen Issue 4

If not specified in the applicable RSS the occupied bandwidth is measured as the 99% emission bandwidth. The span of the analyzer shall be set to capture all products of the modulation process, including the emission skirts. The resolution bandwidth shall be set to as close to 1% of the selected span as is possible without being below 1%. The video bandwidth shall be set to 3 times the resolution bandwidth.

The trace data points are recovered and are directly summed in linear terms. The recovered amplitude data points, beginning at the lowest frequency, are placed in a running sum until 0.5% of the total is reached and that frequency recorded. The process is repeated for the highest frequency data points. This frequency is also recorded. The span between the two recorded frequencies is the occupied bandwidth.

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C20171222 02.Jun 17 23:41

99% OCCUPIED BANDWIDTH Meas Type

ST25R3911B-DISCO **Equipment under Test** 

Manufacturer STMicroelectronics Austria GmbH

WAITING **OP Condition** Andrej Skof Operator

**Test Spec** 

Antenna: 340 deg, Sample: 20 deg

#### **Sweep Settings** Screen A

Center Frequency	13.560000	MHz	Ref Level	73.800	dBµV/m
Frequency Offset	0.000000	Hz	Ref Level Offset	0.000	dB
Span	10.000000	kHz	Ref Position	100.000	용
Start Frequency	13.555000	MHz	Level Range	90.000	dB
Stop Frequency	13.565000	MHz	RF Att	0.000	dB
RBW	1.000000	kHz			
VBW	3.000000	kHz	X-Axis	LIN	
Sweep Time	20.00 ms		Y-Axis	LOG	







**C20171222** 02.Jun 17 23:40

Meas Type 99% OCCUPIED BANDWIDTH

Equipment under Test ST25R3911B-DISCO

Manufacturer STMicroelectronics Austria GmbH

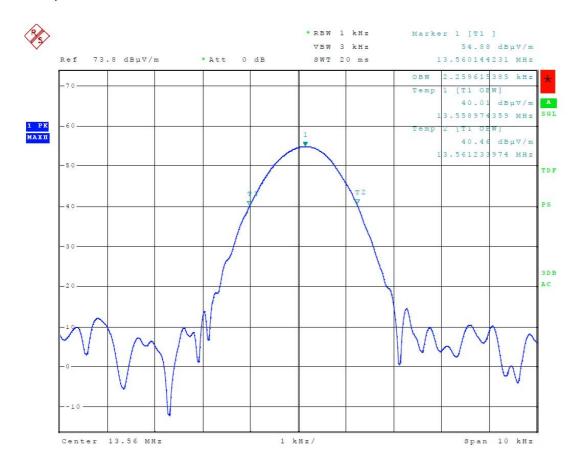
**OP Condition** READING **Operator** Andrej Skof

**Test Spec** 

Antenna: 340 deg, Sample: 20 deg

# Sweep Settings Screen A

Center Frequency	13.560000	MHz	Ref Level	73.800	dBµV/m
Frequency Offset	0.000000	Hz	Ref Level Offset	0.000	dB
Span	10.000000	kHz	Ref Position	100.000	8
Start Frequency	13.555000	MHz	Level Range	90.000	dB
Stop Frequency	13.565000	MHz	RF Att	0.000	dB
RBW	1.000000	kHz			
VBW	3.000000	kHz	X-Axis	LIN	
Sweep Time	20.00 ms		Y-Axis	LOG	



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#### 4.2 Antenna requirements (§15.203)

#### Requirement

An intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device. The use of a permanently attached antenna or of an antenna that uses a unique coupling to the intentional radiator shall be considered sufficient to comply with the provisions of this section. The manufacturer may design the unit so that a broken antenna can be replaced by the user, but the use of a standard antenna jack or electrical connector is prohibited. This requirement does not apply to carrier current devices or to devices operated under the provisions of §15.211, §15.213, §15.217, §15.219, or §15.221. Further, this requirement does not apply to intentional radiators that must be professionally installed, such as perimeter protection systems and some field disturbance sensors, or to other intentional radiators which, in accordance with §15.31(d), must be measured at the installation site. However, the installer shall be responsible for ensuring that the proper antenna is employed so that the limits in this part are not exceeded.

#### Conclusion:

PASS; EUT has PCB antenna which is not detachable



# 4.3 Restricted bands of operation (§15.205 of FCC 47 CRF 15 and Table 6 of RSS-Gen Issue 4)

#### 4.3.1 Requirement

Except as shown in paragraph (d) of §15.205 only spurious emissions are permitted in any of the frequency bands listed below:

MHz	MHz	MHz	GHz
0.090-0.110	16.42-16.423	399.9-410	4.5-5.15
<sup>1</sup> 0.495-0.505	16.69475-16.69525	608-614	5.35-5.46
2.1735-2.1905	16.80425-16.80475	960-1240	7.25-7.75
4.125-4.128	25.5-25.67	1300-1427	8.025-8.5
4.17725-4.17775	37.5-38.25	1435-1626.5	9.0-9.2
4.20725-4.20775	73-74.6	1645.5-1646.5	9.3-9.5
6.215-6.218	74.8-75.2	1660-1710	10.6-12.7
6.26775-6.26825	108-121.94	1718.8-1722.2	13.25-13.4
6.31175-6.31225	123-138	2200-2300	14.47-14.5
8.291-8.294	149.9-150.05	2310-2390	15.35-16.2
8.362-8.366	156.52475-156.52525	2483.5-2500	17.7-21.4
8.37625-8.38675	156.7-156.9	2690-2900	22.01-23.12
8.41425-8.41475	162.0125-167.17	3260-3267	23.6-24.0
12.29-12.293	167.72-173.2	3332-3339	31.2-31.8
12.51975-12.52025	240-285	3345.8-3358	36.43-36.5
12.57675-12.57725	322-335.4	3600-4400	( <sup>2</sup> )
13.36-13.41			

 $<sup>^1 \</sup>text{Until February 1, 1999, this restricted band shall be 0.490-0.510 MHz.}\,^2 \text{Above 38.6}$ 

#### 4.3.2 **Test results**

See Radiated emission results under 4.4 Radiated emission and 4.6 Spectrum mask.

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# 4.4 Conducted emission measurement (§15.207 of FCC 47 CRF 15 and Table 3 of RSS-Gen Issue 4)

#### 4.4.1 Requirement

Frequency Range	Limits (dBμV)				
(MHz)	Quasi-peak	Average			
0.15 to 0.5	66 – 56*	56 – 46*			
0.5 to 5.0	56	46			
5.0 to 30.0	60	50			

<sup>\*</sup> Decreases with the logarithm of the frequency.

The shown limits in table shall not apply to carrier current systems operating as intentional radiators on frequencies below 30 MHz. In lieu thereof, these carrier current systems shall be subject to the following standards:

- For carrier current systems containing their fundamental emission within the frequency band 535-1705 kHz and intended to be received using a standard AM broadcast receiver: no limit on conducted emissions.
- For all other carrier current systems: 1000  $\mu$ V within the frequency band 535-1705 kHz, as measured using a 50  $\mu$ H/50 ohms LISN.
- Carrier current systems operating below 30 MHz are also subject to the radiated emission limits as appropriate.

#### 4.4.2 Test procedure

- As per clause 6.2 from ANSI C63.10-2013.
- The EUT is placed on a non-conductive 0.8 meters high table, 0.4 meters from the vertical conducting wall of the shielded room with EUT being connected to the power mains through a line impedance stabilization network (LISN). LISN provide 50 Ohm / 50  $\mu$ H + 5 Ohm of coupling impedance for the measuring instrument.
- Sufficient time for the EUT, support equipment, and test equipment was allowed in order for them to warm up to their normal operating condition.
- AC power lines of EUT are checked for maximum conducted interference.
- The frequency range from 150 kHz to 30 MHz is searched using PEAK, QUASI-PEAK and AVERAGE function of the receiver to determine compliance with Section 15.207 limits outside the transmitter's fundamental emission band. Bandwidth is set to 9 kHz.
- Measurement is repeated with a dummy load in lieu of the antenna to determine compliance with Section 15.207 limits within the transmitter's fundamental emission band.





#### 4.4.3 Test results

# Device passed the requirements stated

# C20171221

Meas TypeCONDUCTED EMISSIONEquipment under TestX-NUCLEO-NFC05A1

ManufacturerSTMicroelectronics Austria GmbHOP ConditionUin: 120 V, 60 Hz, READING

Operator ANDREJ SKOF

Test Spec PHASE

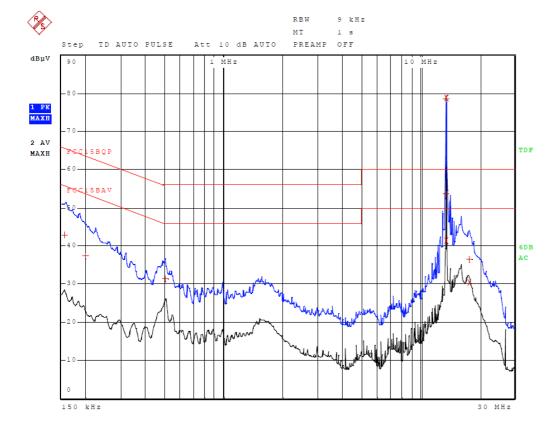
#### Time Domain Scan (1 Range)

Scan Start: 150 kHz Scan Stop: 30 MHz

Detector: Trace 1: MAX PEAK Trace 2: Average

Transducer: ESH2-Z5

Start Frequency	Stop Frequency	Step Size	Res BW	Meas Time	RF Atten	Preamp	Input
requericy	Trequency	Size	IXES DVV	Tillic	Atten	1 Teamp	прис
150 000000 24	30 000000 MH	g 2 25 kHg	9 00 12	30 ma	7) 11 ± 0	O dB	TMDHTTO



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# C20171221

Meas Type CONDUCTED EMISSION Equipment under Test X-NUCLEO-NFC05A1

ManufacturerSTMicroelectronics Austria GmbHOP ConditionUin: 120 V, 60 Hz, READING

Operator ANDREJ SKOF

Test Spec PHASE

# **Final Measurement**

Meas Time:1 sMargin:20 dBSubranges:9

Trace	Frequenc	у	Level (dBµV)	Detector	Delta Limit/dB
2	13.560000000	MHz	78.75	CISPR Avera	g 28.75
1	13.560000000	MHz	78.65	Quasi Peak	18.65
1	13.533000000	MHz	53.60	Quasi Peak	-6.40
2	13.548750000	MHz	41.22	CISPR Avera	g -8.78
2	17.695500000	MHz	30.31	CISPR Avera	g -19.69
1	156.750000000	kHz	42.82	Quasi Peak	-22.81
1	17.682000000	MHz	36.34	Quasi Peak	-23.66
1	503.250000000	kHz	31.22	Quasi Peak	-24.78
1	197.250000000	kHz	37.25	Quasi Peak	-26.48





# C20171221

Meas Type CONDUCTED EMISSION
Equipment under Test X-NUCLEO-NFC05A1

Manufacturer STMicroelectronics Austria GmbH
OP Condition Uin: 120 V, 60 Hz, READING

Operator ANDREJ SKOF

Test Spec NEUTRAL

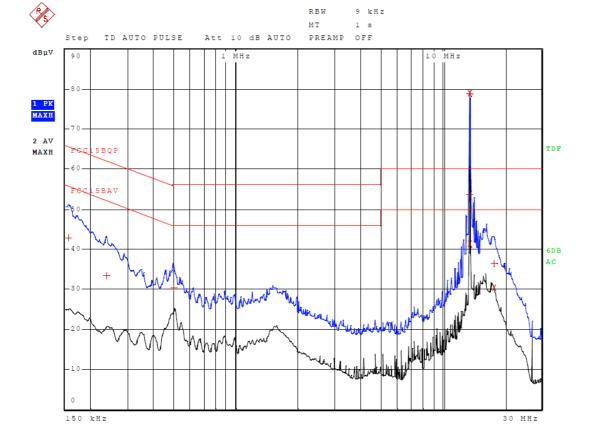
# Time Domain Scan (1 Range)

Scan Start: 150 kHz Scan Stop: 30 MHz

Detector: Trace 1: MAX PEAK Trace 2: Average

Transducer: ESH2-Z5

Start	Stop	Step	Dec DW	Meas	RF Attau	D	l4
Frequency	Frequency	Size	Res BW	Time	Atten	Preamp	Input
150 000000 ki	4- 30 000000 N	MH 2 2 25 kHz	9 NN 1/Hz	30 mg	Δuto	0 dB	TMPHTT2



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# C20171221

Meas Type CONDUCTED EMISSION Equipment under Test X-NUCLEO-NFC05A1

ManufacturerSTMicroelectronics Austria GmbHOP ConditionUin: 120 V, 60 Hz, READING

Operator ANDREJ SKOF

Test Spec NEUTRAL

# **Final Measurement**

Meas Time: 1 s Margin: 20 dB Subranges: 9

Trace	Frequenc	у	Level (dBμV)	Detector	Delta Limit/dB
2	13.560000000	MHz	78.85	CISPR Avera	g 28.85
1	13.560000000	MHz	78.76	Quasi Peak	18.76
1	13.533000000	MHz	53.69	Quasi Peak	-6.31
2	13.548750000	MHz	41.37	CISPR Avera	g -8.63
2	17.704500000	MHz	30.38	CISPR Avera	g -19.62
1	154.500000000	kHz	42.82	Quasi Peak	-22.93
1	17.702250000	MHz	36.38	Quasi Peak	-23.62
1	496.500000000	kHz	30.43	Quasi Peak	-25.62
1	235.500000000	kHz	33.29	Quasi Peak	-28.97





# C20171221

Meas Type CONDUCTED EMISSION Equipment under Test X-NUCLEO-NFC05A1

Manufacturer STMicroelectronics Austria GmbH
OP Condition Uin: 120 V, 60 Hz, WAITING

Operator ANDREJ SKOF

Test Spec PHASE

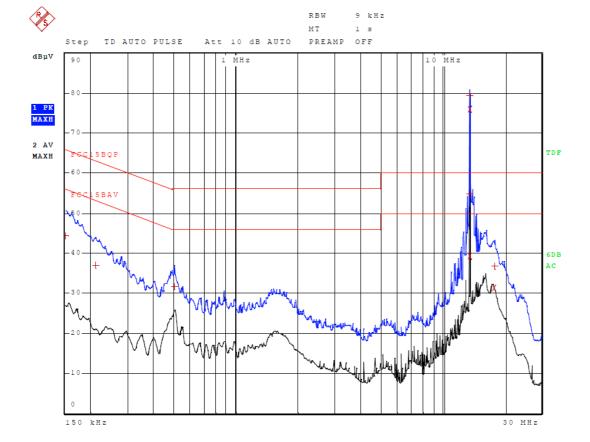
# Time Domain Scan (1 Range)

Scan Start: 150 kHz Scan Stop: 30 MHz

Detector: Trace 1: MAX PEAK Trace 2: Average

Transducer: ESH2-Z5

		Step		Meas	leas RF		
Frequency	Frequency	Size	Res BW	Time	Atten	Preamp	Input
150 000000 kHz	30 000000 MHz	2 25 kHz	9 00 kHz	30 mg	Auto	0 dB	TMPHT2



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# C20171221

Meas Type CONDUCTED EMISSION Equipment under Test X-NUCLEO-NFC05A1

ManufacturerSTMicroelectronics Austria GmbHOP ConditionUin: 120 V, 60 Hz, WAITING

Operator ANDREJ SKOF

Test Spec PHASE

# **Final Measurement**

Meas Time: 1 s Margin: 20 dB Subranges: 9

Trace	Frequenc	у	Level (dBµV)	Detector	Delta Limit/dB
2	13.560000000	MHz	75.97	CISPR Ave	rag 25.97
1	13.560000000	MHz	79.25	Quasi Peal	19.25
1	13.548750000	MHz	54.79	Quasi Peal	-5.21
2	13.548750000	MHz	39.30	CISPR Ave	rag -10.70
2	17.704500000	MHz	31.38	CISPR Ave	rag -18.62
1	150.000000000	kHz	44.41	Quasi Peal	-21.59
1	17.796750000	MHz	36.78	Quasi Peal	-23.22
1	501.000000000	kHz	31.63	Quasi Peal	-24.37
1	208.500000000	kHz	37.00	Quasi Peal	-26.27





# C20171221

Meas Type CONDUCTED EMISSION
Equipment under Test X-NUCLEO-NFC05A1

Manufacturer STMicroelectronics Austria GmbH
OP Condition Uin: 120 V, 60 Hz, WAITING

Operator ANDREJ SKOF

Test Spec NEUTRAL

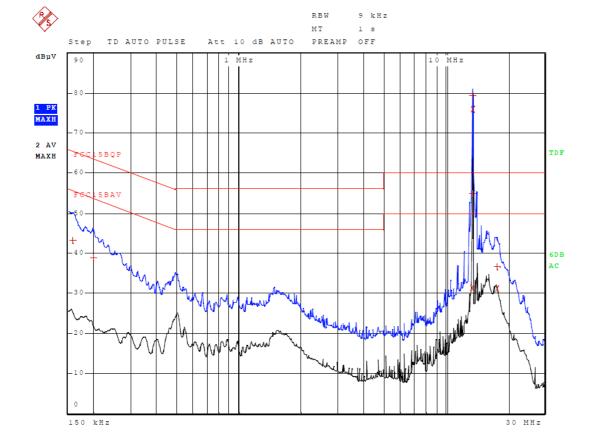
# Time Domain Scan (1 Range)

Scan Start: 150 kHz Scan Stop: 30 MHz

Detector: Trace 1: MAX PEAK Trace 2: Average

Transducer: ESH2-Z5

		Step		Meas	leas RF		
Frequency	Frequency	Size	Res BW	Time	Atten	Preamp	Input
150 000000 kHz	30 000000 MHz	2 25 kHz	9 00 kHz	30 mg	Auto	0 dB	TMPHT2



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# C20171221

Meas Type CONDUCTED EMISSION Equipment under Test X-NUCLEO-NFC05A1

ManufacturerSTMicroelectronics Austria GmbHOP ConditionUin: 120 V, 60 Hz, WAITING

Operator ANDREJ SKOF

Test Spec NEUTRAL

# **Final Measurement**

Meas Time: 1 s Margin: 20 dB Subranges: 8

Trace	Frequenc	у	Level (dΒμV)	Detector	Delta Limit/dB
2	13.560000000	MHz	76.00	CISPR Aver	ag 26.00
1	13.560000000	MHz	79.38	Quasi Peak	19.38
1	13.548750000	MHz	54.91	Quasi Peak	-5.09
2	13.348500000	MHz	31.24	CISPR Aver	ag -18.76
2	17.704500000	MHz	31.03	CISPR Aver	ag -18.97
1	159.000000000	kHz	43.12	Quasi Peak	-22.39
1	17.720250000	MHz	36.64	Quasi Peak	-23.36
1	197.250000000	kHz	38.77	Quasi Peak	-24.95



# Measurement with a dummy load in lieu of the antenna:



C20171221 16.May 17 10:31

 Meas Type
 CONDUCTED EMISSION

 Equipment under Test
 X-NUCLEO-NFC05A1

ManufacturerSTMicroelectronics Austria GmbHOP ConditionUin: 120 V, 60 Hz; with Dummy load

Operator ANDREJ SKOF

Test Spec PHASE

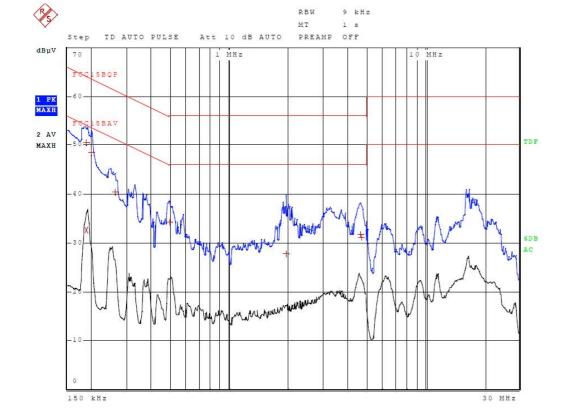
#### Time Domain Scan (1 Range)

Scan Start: 150 kHz Scan Stop: 30 MHz

Detector: Trace 1: MAX PEAK Trace 2: Average

Transducer: ESH2-Z5

Start	Stop	Step		Meas	RF		
Frequency	Frequency	Size	Res BW	Time	Atten	Preamp	Input
150.000000 kHz	30.000000 MHz	2.25 kHz	9.00 kHz	20 ms	Auto	0 dB	INPUT2



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**C20171221** 16.May 17 10:31

Meas Type CONDUCTED EMISSION Equipment under Test X-NUCLEO-NFC05A1

Manufacturer STMicroelectronics Austria GmbH
OP Condition Uin: 120 V, 60 Hz; with Dummy load

Operator ANDREJ SKOF

Test Spec PHASE

# **Final Measurement**

Meas Time: 1 s Margin: 18 dB Subranges: 8

Trace	Frequenc	у	Level (dBµV)	Detecto	or	Delta Limit/dB
1	188.250000000	kHz	50.58	Quasi	Peak	-13.53
1	197.250000000	kHz	48.51	Quasi	Peak	-15.21
1	260.250000000	kHz	40.37	Quasi	Peak	-21.05
2	188.250000000	kHz	32.55	CISPR	Averag	-21.57
1	494.250000000	kHz	34.26	Quasi	Peak	-21.84
1	4.665750000	MHz	31.67	Quasi	Peak	-24.33
1	4.715250000	MHz	31.12	Quasi	Peak	-24.88
1	1.943250000	MHz	27.70	Quasi	Peak	-28.30







**C20171221** 16.May 17 10:24

Meas Type CONDUCTED EMISSION Equipment under Test X-NUCLEO-NFC05A1

Manufacturer STMicroelectronics Austria GmbH
OP Condition Uin: 120 V, 60 Hz; with Dummy load

Operator ANDREJ SKOF

Test Spec NEUTRAL

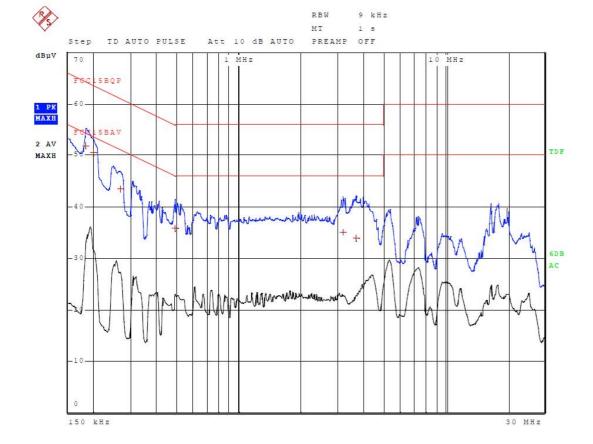
# Time Domain Scan (1 Range)

Scan Start: 150 kHz Scan Stop: 30 MHz

Detector: Trace 1: MAX PEAK Trace 2: Average

Transducer: ESH2-Z5

Start	Stop	Step		Meas	RF		
Frequency	Frequency	Size	Res BW	Time	Atten	Preamp	Input
150.000000 kHz	30.000000 MHz	2.25 kHz	9.00 kHz	20 ms	Auto	0 dB	TNPHT2



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**C20171221** 16.May 17 10:24

Meas Type CONDUCTED EMISSION Equipment under Test X-NUCLEO-NFC05A1

Manufacturer STMicroelectronics Austria GmbH
OP Condition Uin: 120 V, 60 Hz; with Dummy load

Operator ANDREJ SKOF

Test Spec NEUTRAL

# **Final Measurement**

Meas Time: 1 s Margin: 15 dB Subranges: 6

Trace	Frequency		Level (dBµV)	Detecto	or	Delta Limit/dB	
1	181.500000000	kHz	51.82	Quasi	Peak	-12.60	
1	197.250000000	kHz	50.49	Quasi	Peak	-13.23	
1	264.750000000	kHz	43.39	Quasi	Peak	-17.89	
1	489.750000000	kHz	35.75	Quasi	Peak	-20.42	
1	3.192000000	MHz	35.00	Quasi	Peak	-21.00	
1	3.696000000	MHz	33.93	Ouasi	Peak	-22.07	



# 4.5 Radiated emission measurement (§15.209 of FCC 47 CRF 15 and Tables 4 and 5 of RSS-Gen Issue 4)

#### 4.5.1 Requirement

Frequency Range (MHz)	Limits (dBμV/m)	Test distance (m)
0.009 to 0.490	20*log(2400/F(kHz))	300
0.490 to 1.705	20*log(24000/F(kHz))	30
1.705 to 30.0	30	30
30 to 88	40**	3
88 to 216	43.5**	3
216 to 960	46**	3
Above 960	54	3

<sup>\*\*</sup> Except as provided in paragraph below, fundamental emissions from intentional radiators operating under this section shall not be located in the frequency bands 54-72 MHz, 76-88 MHz, 174-216 MHz or 470-806 MHz.

Perimeter protection systems may operate in the 54-72 MHz and 76-88 MHz bands under the provisions of this section. The use of such perimeter protection systems is limited to industrial, business and commercial applications

#### 4.5.2 Test procedure

#### Measurements from 9 kHz to 30 MHz

- 1. As per clause 6.4 from ANSI C63.10-2013
- 2. Radiated emission in the frequency range 9 kHz to 30 MHz are measured Active loop Antenna.
- 3. First preliminary measurements were performed in Semi-anechoic chamber at a distance of 3 m using active loop antenna.
- 4. The EUT was placed on the top of a rotating table 0.8 meters above the ground in an Anechoic Chamber. The table and antenna was rotated 360 degrees to determine the position of the highest radiation.
- 5. Final measurements were done at a distance of 10 m at Open Area Test Site due to low emissions measured during preliminary measurements acc. to the clauses from Part 15, Sections 15.31(d) and 15.31(f)(2). Test results were extrapolated by using the square of an inverse linear distance extrapolation factor (40 dB/decade).

#### Measurements from 30 MHz to 1 GHz

- 6. As per clause 6.5 from ANSI C63.10-2013
- 7. The EUT was placed on the top of a rotating table 0.8 meters above the ground in an Anechoic Chamber. The table was rotated 360 degrees to determine the position of the highest radiation.
- 8. The EUT was set 3 m away from the interference-receiving antenna, which was mounted on the top of variable-height antenna tower.
- The antenna is a broadband antenna, and its height is varied from one meter to four meters above the ground to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- 10. For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights from 1 meter to 4 meters and the turn table was turned from 0 degrees to 360 degrees to find the maximum reading.
- 11. The test-receiver system was set to PEAK and QUAS-PEAK Detect Function and Specified Bandwidth with Maximum Hold Mode.
- 12. The highest points would be re-tested one by one using the quasi-peak method.

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#### 4.5.3 Test results

Device passed the requirements stated Preliminary measurements at 3 m:



C20171221 03.May 17 13:00

Meas Type RADIATED EMISSION
Equipment under Test X-NUCLEO-NFC05A1

Manufacturer STMicroelectronics Austria GmbH

OP Condition READING
Operator ANDREJ SKOF

**Test Spec** 

Antenna: 350 deg, Sample: 10 deg

# Time Domain Scan (2 Ranges)

Scan Start: 9 kHz Scan Stop: 30 MHz

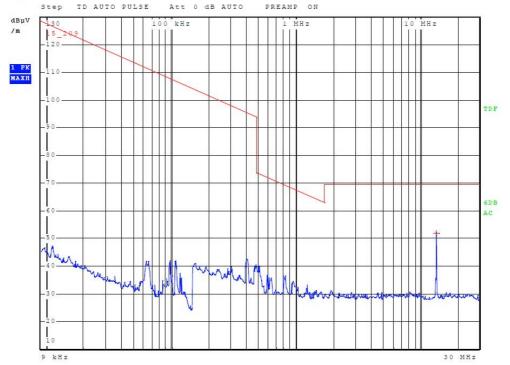
Detector: Trace 1: MAX PEAK

Transducer: HFH2-Z2V

Start Frequency		Stop Frequency		Step Size Res BW		Meas Time		RF Atten	Preamp	Input	
9.000000	kHz	149.950000	kHz	50.00	Hz	200.00	Hz	300 ms	Auto	20 dB	INPUT2
150.000000	kHz	30.000000	MHz	2.25	kHz	9.00	kHz	30 ms	Auto	20 dB	INPUT2



RBW 9 kH:





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**C20171221** 03.May 17 13:00

Meas TypeRADIATED EMISSIONEquipment under TestX-NUCLEO-NFC05A1

Manufacturer STMicroelectronics Austria GmbH

OP Condition READING
Operator ANDREJ SKOF

**Test Spec** 

Antenna: 350 deg, Sample: 10 deg

# **Final Measurement**

Meas Time:1 sMargin:20 dBSubranges:1

Trace	Frequency	Level (dBµV/m)	Detector	Delta Limit/dB
1	13.560000000 MHz	51.63	Quasi Peak	-17.87

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**C20171221** 03.May 17 13:02

Meas Type RADIATED EMISSION
Equipment under Test X-NUCLEO-NFC05A1

Manufacturer STMicroelectronics Austria GmbH

OP Condition WAITING
Operator ANDREJ SKOF

**Test Spec** 

Antenna: 350 deg, Sample: 10 deg

# Time Domain Scan (2 Ranges)

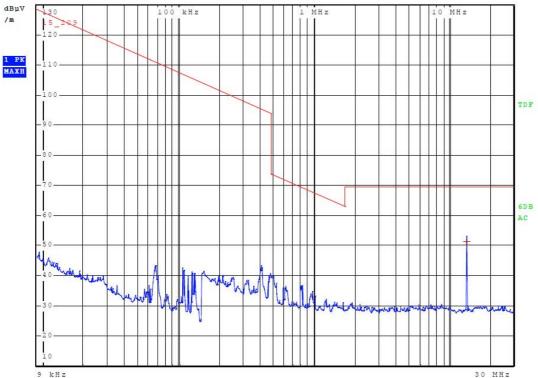
Scan Start: 9 kHz Scan Stop: 30 MHz

Detector: Trace 1: MAX PEAK

Transducer: HFH2-Z2V

Start		Stop		Step Size Res				Meas	RF		
Frequency		Frequency				Res BW		Time	Atten	Preamp	Input
9.000000	kHz	149.950000	kHz	50.00	Hz	200.00	Hz	300 ms	Auto	20 dB	INPUT2
150.000000	kHz	30.000000	MHz	2.25	kHz	9.00	kHz	30 ms	Auto	20 dB	INPUT2













**C20171221** 03.May 17 13:02

Meas TypeRADIATED EMISSIONEquipment under TestX-NUCLEO-NFC05A1

Manufacturer STMicroelectronics Austria GmbH

OP Condition WAITING
Operator ANDREJ SKOF

**Test Spec** 

Antenna: 350 deg, Sample: 10 deg

# **Final Measurement**

Meas Time:1 sMargin:20 dBSubranges:1

Trace	Frequency	Level (dBµV/m)	Detector	Delta Limit/dB	
1	13.560000000 MHz	51.28	Quasi Peak	-18.22	

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# Final measurement at 10 m on OATS

Results with measuring distance of 10 m										
Mode	Frequency (MHz)	Measured value (dBμV/m)	Limit (dBµV/m)	Margin (dB)						
Reading	13.56	33.93	104.00	70.07						
Waiting	13.56	33.86	104.00	70.14						

Calculated value from 10 m to 30 m										
Mode	Frequency (MHz)	Measured value at 10 m (dBμV/m)	Correction factor from 10 m to 30 m (dB)	Calculated value at 30 m (dB <sub>μ</sub> V/m)	Limit at 30 m (dBμV/m)	Margin (dB)				
Reading	13.56	33.93	20	13.93	84.00	70.07				
Waiting	13.56	33.86	20	13.86	84.00	70.14				

**NOTE:** Antenna factor and cable loss are included in measurement correction.





#### Final measurements from 30 MHz to 1 GHz

**C20171221** 26.Apr 17 06:34

Meas Type RADIATED EMISSION
Equipment under Test X-NUCLEO-NFC05A1

Manufacturer STMicroelectronics Austria GmbH

OP Condition READING
Operator ANDREJ SKOF

**Test Spec** 

VERTICAL 100 cm, 0 deg

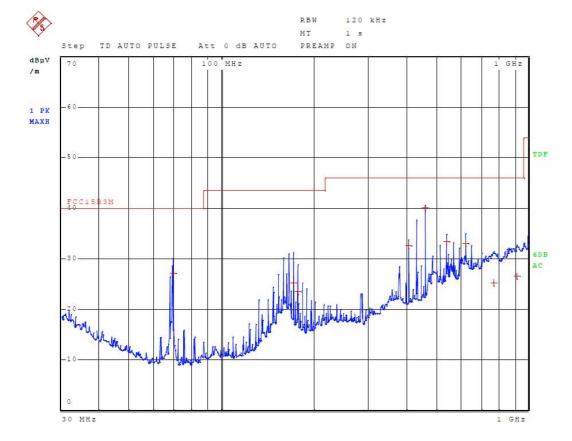
#### Time Domain Scan (1 Range)

Scan Start: 30 MHz Scan Stop: 1 GHz

Detector: Trace 1: MAX PEAK

Transducer: 3142B-3M

Start	Stop	Step		Meas	RF		
Frequency	Frequency	Size	Res BW	Time	Atten	Preamp	Input
30.000000 MHz	1.000000 G	Hz 30.00 kHz	120.00 kHz	5 ms	Auto	20 dB	INPUT2



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**C20171221** 26.Apr 17 06:34

Meas Type RADIATED EMISSION Equipment under Test X-NUCLEO-NFC05A1

Manufacturer STMicroelectronics Austria GmbH

OP Condition READING
Operator ANDREJ SKOF

**Test Spec** 

VERTICAL 100 cm, 0 deg

#### **Final Measurement**

Meas Time: 1 s Margin: 15 dB Subranges: 9

Trace	Frequency		Level (dBµV/m)	Detector	Delta Limit/dB	
1	461.040000000	MHz	40.08	Quasi Peak	-5.92	
1	542.400000000	MHz	33.27	Quasi Peak	-12.73	
1	69.150000000	MHz	27.10	Quasi Peak	-12.90	
1	623.760000000	MHz	33.08	Quasi Peak	-12.92	
1	406.800000000	MHz	32.60	Quasi Peak	-13.40	
1	171.270000000	MHz	25.27	Quasi Peak	-18.23	
1	921.240000000	MHz	26.60	Quasi Peak	-19.40	
1	177.330000000	MHz	23.50	Quasi Peak	-20.00	
7	773.310000000	MHz	25.28	Ouasi Peak	-20.72	



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**C20171221** 26.Apr 17 06:41

Meas Type RADIATED EMISSION
Equipment under Test X-NUCLEO-NFC05A1

Manufacturer STMicroelectronics Austria GmbH

OP Condition READING
Operator ANDREJ SKOF

**Test Spec** 

HORIZONTAL 100 cm, 0 deg

#### Time Domain Scan (1 Range)

Scan Start: 30 MHz Scan Stop: 1 GHz

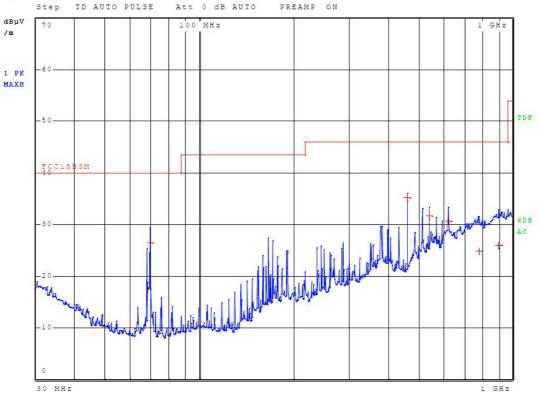
Detector: Trace 1: MAX PEAK

Transducer: 3142B-3M

Start	Stop	Step		Meas	RF		
Frequency	Frequency	Size	Res BW	Time	Atten	Preamp	Input
30.000000 MHz	1.000000 GI	1z 30.00 kHz	120.00 kHz	5 ms	Auto	20 dB	TNPUT2



RBW 120 kHz
MT 1 s
PREAMP ON



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**C20171221** 26.Apr 17 06:41

Meas Type RADIATED EMISSION Equipment under Test X-NUCLEO-NFC05A1

Manufacturer STMicroelectronics Austria GmbH

OP Condition READING
Operator ANDREJ SKOF

**Test Spec** 

HORIZONTAL 100 cm, 0 deg

#### **Final Measurement**

Meas Time: 1 s Margin: 15 dB Subranges: 6

Trace	Frequency		Level (dBµV/m)	Detector		Delta Limit/dB	
1	461.040000000	MHz	35.23	Quasi	Peak		-10.77
1	69.180000000	MHz	26.46	Quasi	Peak		-13.54
1	542.400000000	MHz	31.64	Quasi	Peak		-14.36
1	623.760000000	MHz	30.61	Quasi	Peak		-15.39
1	905.010000000	MHz	25.90	Quasi	Peak		-20.10
1	781.020000000	MHz	24.83	Ouasi	Peak		-21.17



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**C20171221** 26.Apr 17 06:45

Meas Type RADIATED EMISSION
Equipment under Test X-NUCLEO-NFC05A1

Manufacturer STMicroelectronics Austria GmbH

OP Condition WAITING
Operator ANDREJ SKOF

**Test Spec** 

VERTICAL 100 cm, 0 deg

# Time Domain Scan (1 Range)

Scan Start: 30 MHz Scan Stop: 1 GHz

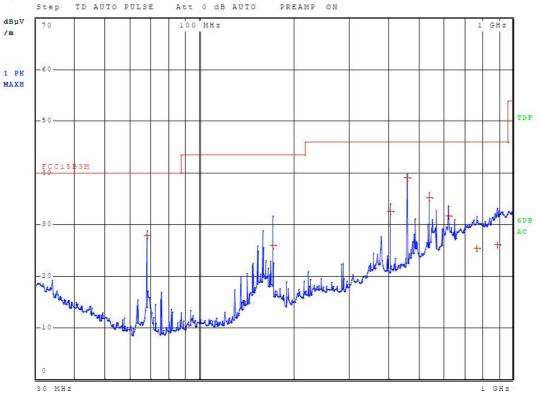
Detector: Trace 1: MAX PEAK

Transducer: 3142B-3M

Start	Stop	Step	Res BW	Meas Time	RF Atten	Preamp	Input
Frequency	Frequency	Size					
30.000000 MHz	1.000000 G	Hz 30.00 kHz	120.00 kHz	5 ms	Auto	20 dB	TNPUT2



RBW 120 kHz MT 1 s O PREAMP ON



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**C20171221** 26.Apr 17 06:45

Meas Type RADIATED EMISSION Equipment under Test X-NUCLEO-NFC05A1

Manufacturer STMicroelectronics Austria GmbH

OP Condition WAITING
Operator ANDREJ SKOF

**Test Spec** 

VERTICAL 100 cm, 0 deg

#### **Final Measurement**

Meas Time: 1 s Margin: 15 dB Subranges: 8

Trace	Frequency		Level (dBµV/m)	Detector		Delta Limit/dB	
	461.040000000	MHz	39.09	Quasi	Peak	-6.91	
1	542.400000000	MHz	35.25	Quasi	Peak	-10.75	
1	67.800000000	MHz	27.85	Quasi	Peak	-12.15	
1	406.800000000	MHz	32.65	Quasi	Peak	-13.35	
1	623.760000000	MHz	31.67	Quasi	Peak	-14.33	
1	171.510000000	MHz	25.89	Quasi	Peak	-17.61	
1	893.160000000	MHz	26.03	Quasi	Peak	-19.97	
1	767.970000000	MHz	25.31	Ouasi	Peak	-20.69	





**C20171221** 26.Apr 17 06:43

Meas Type RADIATED EMISSION
Equipment under Test X-NUCLEO-NFC05A1

Manufacturer STMicroelectronics Austria GmbH

OP Condition WAITING
Operator ANDREJ SKOF

**Test Spec** 

HORIZONTAL 100 cm, 0 deg

#### Time Domain Scan (1 Range)

Scan Start: 30 MHz Scan Stop: 1 GHz

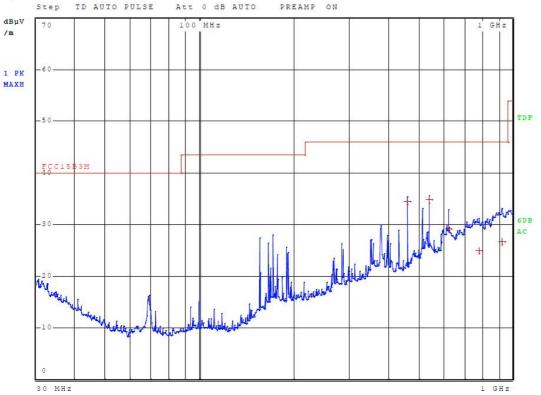
Detector: Trace 1: MAX PEAK

Transducer: 3142B-3M

Start	Stop	Step		Meas	RF		
Frequency	Frequency	Size	Res BW	Time	Atten	Preamp	Input
30.000000 MHz	1.000000 GI	1z 30.00 kHz	120.00 kHz	5 ms	Auto	20 dB	TNPUT2



RBW 120 kHz MT 1 s O PREAMP ON



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**C20171221** 26.Apr 17 06:43

Meas TypeRADIATED EMISSIONEquipment under TestX-NUCLEO-NFC05A1

Manufacturer STMicroelectronics Austria GmbH

OP Condition WAITING
Operator ANDREJ SKOF

**Test Spec** 

HORIZONTAL 100 cm, 0 deg

#### **Final Measurement**

Meas Time: 1 s Margin: 15 dB Subranges: 5

Trace	Frequenc	y	Level (dBµV/m)	Detecto	or	Delta Limit/d	ta Limit/dB	
1	542.400000000	MHz	34.77	Quasi	Peak	-2	11.23	
1	461.040000000	MHz	34.51	Quasi	Peak	=	11.49	
1	623.790000000	MHz	29.20	Quasi	Peak	_	16.80	
1	922.890000000	MHz	26.64	Quasi	Peak	=	19.36	
1	780.360000000	MHz	24.89	Onasi	Peak	_2	21.11	





#### Worst case measurement:

**C20171221** 26.Apr 17 07:14

Meas TypeRADIATED EMISSIONEquipment under TestX-NUCLEO-NFC05A1

Manufacturer STMicroelectronics Austria GmbH

OP Condition READING
Operator ANDREJ SKOF

**Test Spec** 

VERTICAL 100 cm, 170 deg

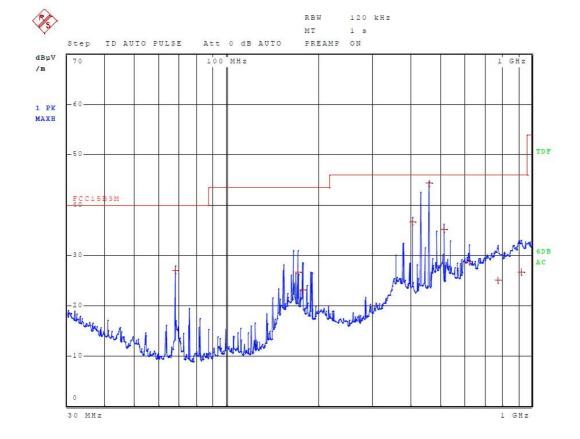
## Time Domain Scan (1 Range)

Scan Start: 30 MHz Scan Stop: 1 GHz

Detector: Trace 1: MAX PEAK

Transducer: 3142B-3M

Start	Stop	Step		Meas	RF		
Frequency	Frequency	Size	Res BW	Time	Atten	Preamp	Input
30 000000 MH	- 1 000000 G	H= 30 00 kH=	120 00 144	5 mg	Auto	20 dB	TNPHT2



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**C20171221** 26.Apr 17 07:14

Meas Type RADIATED EMISSION Equipment under Test X-NUCLEO-NFC05A1

Manufacturer STMicroelectronics Austria GmbH

OP Condition READING
Operator ANDREJ SKOF

**Test Spec** 

VERTICAL 100 cm, 170 deg

#### **Final Measurement**

Meas Time: 1 s Margin: 18 dB Subranges: 9

Trace	Frequenc	у	Level (dBµV/m)	Detector	Delta Limit/dB
1	461.040000000	MHz	44.34	Quasi Pe	ak -1.66
1	406.800000000	MHz	36.69	Quasi Pe	ak -9.31
1	515.280000000	MHz	35.16	Quasi Pe	ak -10.84
1	67.800000000	MHz	27.06	Quasi Pe	ak -12.94
1	171.480000000	MHz	26.64	Quasi Pe	ak -16.86
1	623.790000000	MHz	28.79	Quasi Pe	ak -17.21
1	926.460000000	MHz	26.64	Quasi Pe	ak -19.36
1	177.600000000	MHz	23.18	Quasi Pe	ak -20.32
1	778.410000000	MHz	25.05	Quasi Pe	ak -20.95



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## 4.6 Bandwidth of the emission (§15.215)

#### 4.6.1 Requirements

Intentional radiators operating under the alternative provisions to the general emission limits, as contained in §15.217 through 15.257 and in subpart E of FCC Part 15, must be designed to ensure that the 20 dB bandwidth of the emission, or whatever bandwidth may otherwise be specified in the specific rule section under which the equipment operates, is contained within the frequency band designated in the rule section under which the equipment is operated.

#### 4.6.2 Test procedure

- 1. As per Clause 6.9.2 from ANSI C63.10-2013
- 2. The EUT is placed on the top of a rotating table 0.8 meters above the ground in an Anechoic Chamber. The table is rotated 360 degrees to determine the position of the highest radiation.
- 3. The EUT is set 3 m away from the interference-receiving antenna.
- 4. Resolution bandwidth is set to a value greater than 5% of the allowed bandwidth.

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### 4.6.3 Test results Device passed the requirements stated



C20171221 03.May 17 13:24

Meas Type OCCUPIED BANDWIDTH X-NUCLEO-NFC05A1 **Equipment under Test** 

Manufacturer STMicroelectronics Austria GmbH

**OP Condition** READING Operator ANDREJ SKOF

**Test Spec** 

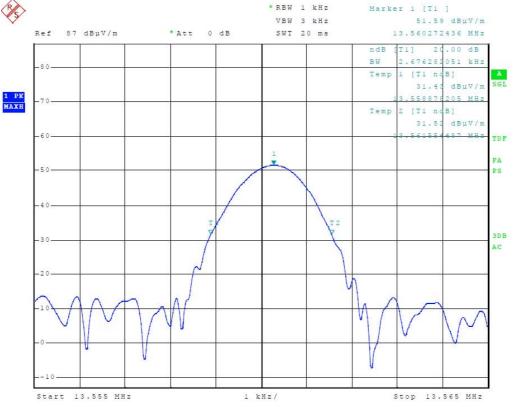
Antenna: 350 deg, Sample: 10 deg

#### **Sweep Settings** Screen A

Center Frequency	13.560000	MHz	Ref Level	87.000	dBµV/m
Frequency Offset	0.000000	Hz	Ref Level Offset	0.000	dB
Span	10.000000	kHz	Ref Position	100.000	્ર
Start Frequency	13.555000	MHz	Level Range	100.000	dB
Stop Frequency	13.565000	MHz	RF Att	0.000	dB
RBW	1.000000	kHz			
VBW	3.000000	kHz	X-Axis	LIN	
Sweep Time	20.00 ms		Y-Axis	LOG	

RBW 1 kHz







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**C20171221** 03.May 17 13:23

Meas TypeOCCUPIED BANDWIDTHEquipment under TestX-NUCLEO-NFC05A1

Manufacturer STMicroelectronics Austria GmbH

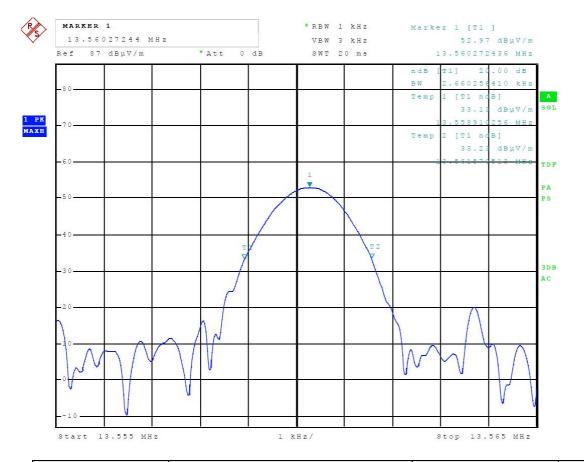
OP Condition WAITING
Operator ANDREJ SKOF

**Test Spec** 

Antenna: 350 deg, Sample: 10 deg

## Sweep Settings Screen A

Center Frequency	13.560000	MHz	Ref Level	87.000	dBµV/m
Frequency Offset	0.000000	Hz	Ref Level Offset	0.000	dB
Span	10.000000	kHz	Ref Position	100.000	상
Start Frequency	13.555000	MHz	Level Range	100.000	dB
Stop Frequency	13.565000	MHz	RF Att	0.000	dB
RBW	1.000000	kHz			
VBW	3.000000	kHz	X-Axis	LIN	
Sweep Time	20.00 ms		Y-Axis	LOG	



Frequency (MHz)	Permitted frequency band (MHz)	20 dB bandwidth (kHz)	PASS/FAIL
13.56	13.110 – 14.010	2.68	PASS

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# 4.7 Spectrum mask (§15.225 (a)-(d) of FCC 47 CRF 15 and Annex B.6 of RSS-210 issue 9)

#### 4.7.1 Requirements

The field strength of any emissions within the band 13.553-13.567 MHz shall not exceed 15,848 microvolts/meter at 30 meters. Within the bands 13.410-13.553 MHz and 13.567-13.710 MHz, the field strength of any emissions shall not exceed 334 microvolts/meter at 30 meters. Within the bands 13.110-13.410 MHz and 13.710-14.010 MHz the field strength of any emissions shall not exceed 106 microvolts/meter at 30 meters. The field strength of any emissions appearing outside of the 13.110-14.010 MHz band shall not exceed the general radiated emission limits in §15.209.

## 4.7.2 Test procedure

- 1. As per clause 6.4 from ANSI C63.10-2013
- 2. The EUT was placed on the top of a rotating table 0.8 meters above the ground in an Anechoic Chamber. The table was rotated 360 degrees to determine the position of the highest radiation.
- 3. The EUT was set 3 m away from the interference-receiving antenna.
- 4. Frequencies with maximum emission were retested on OATS.
- 5. For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights from 1 meter to 4 meters and the turn table was turned from 0 degrees to 360 degrees to find the maximum reading.





## 4.7.3 Test results Device passed the requirements stated



**C20171221** 03.May 17 13:30

 Meas Type
 SPECTRUM MASK

 Equipment under Test
 X-NUCLEO-NFC05A1

Manufacturer STMicroelectronics Austria GmbH

OP Condition READING
Operator ANDREJ SKOF

**Test Spec** 

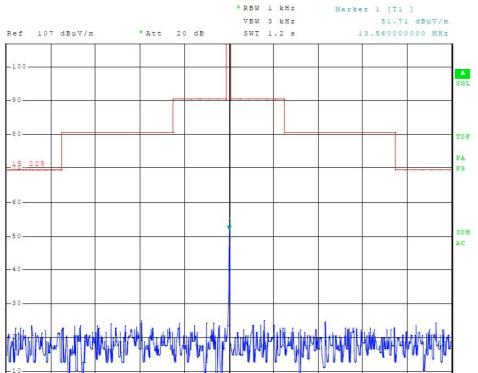
Antenna: 350 deg, Sample: 10 deg

Center 13.56 MHz

## Sweep Settings Screen A

Center Frequency	13.560000	MHz	Ref Level	107.000	dBµV/m
Frequency Offset	0.000000	Hz	Ref Level Offset	0.000	dB
Span	1.200000	MHz	Ref Position	100.000	용
Start Frequency	12.960000	MHz	Level Range	100.000	dB
Stop Frequency	14.160000	MHz	RF Att	20.000	dB
RBW	1.000000	kHz			
VBW	3.000000	kHz	X-Axis	LIN	
Sweep Time	1.20 s		Y-Axis	LOG	





120 kHz/

Span 1.2 MHz

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C20171221 03.May 17 13:31

Meas Type SPECTRUM MASK
Equipment under Test X-NUCLEO-NFC05A1

Manufacturer STMicroelectronics Austria GmbH

OP Condition WAITING
Operator ANDREJ SKOF

**Test Spec** 

Antenna: 350 deg, Sample: 10 deg

## Sweep Settings Screen A

Center Frequency	13.560000	MHz	Ref Level	107.000	dBµV/m
Frequency Offset	0.000000	Hz	Ref Level Offset	0.000	dB
Span	1.200000	MHz	Ref Position	100.000	용
Start Frequency	12.960000	MHz	Level Range	100.000	dB
Stop Frequency	14.160000	MHz	RF Att	20.000	dB
RBW	1.000000	kHz			
VBW	3.000000	kHz	X-Axis	LIN	
Sweep Time	1.20 s		Y-Axis	LOG	



1 PK MAXH



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## 4.8 Frequency tolerance of the carrier signal (§15.225 (e))

#### 4.8.1 Requirement

The frequency tolerance of the carrier signal shall be maintained within +/- 0.01% of the operating frequency over a temperature variation of -20 degrees to +50 degrees C at normal supply voltage, and for a variation in the primary supply voltage from 85% to 115% of the rated supply voltage at a temperature of 20 degrees C. For battery operated equipment, the equipment tests shall be performed using a new battery.

#### 4.8.2 Test procedure

- 1. As per clause 6.8 from ANSI C63.10-2013.
- 2. The frequency tolerance of the carrier signal is measured over a temperature variation of -20 °C to +50 °C at normal supply voltage, and for a variation in the primary supply voltage from 85% to 115% of the rated supply voltage at a temperature of 20 °C.
- 3. If the EUT provides an antenna connector the spectrum analyzer is connected to this port. In cases where the EUT does not provide an antenna connector a test fixture is used.
- 4. The peak detector of the spectrum analyzer is selected and the resolution bandwidth as well as the video bandwidth is set to values appropriate to the shape of the spectrum of the EUT.
- 5. While maintaining a constant temperature inside the environmental chamber, turn the EUT ON and record the operating frequency at startup, and at 2 minutes, 5 minutes, and 10 minutes after the EUT is energized.

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## 4.8.3 Test results

Device passed the requirements stated

Device passes	u the requirement	nto stated			•	
Temperature (°C)	Supply voltage (V DC)	Minutes after switch on	Measured Frequency (MHz)	Allowed tolerance (kHz)	Measured tolerance (kHz)	RESULT
50	5,00	0	13,560224700	Fref±1.356 kHz	-0,054	PASS
50	5,00	2	13,560222700	Fref±1.356 kHz	-0,056	PASS
50	5,00	5	13,560224700	Fref±1.356 kHz	-0,054	PASS
50	5,00	10	13,560224700	Fref±1.356 kHz	-0,054	PASS
40	5,00	0	13,560233700	Fref±1.356 kHz	-0,045	PASS
40	5,00	2	13,560227700	Fref±1.356 kHz	-0,051	PASS
40	5,00	5	13,560228700	Fref±1.356 kHz	-0,050	PASS
40	5,00	10	13,560229700	Fref±1.356 kHz	-0,049	PASS
30	5,00	0	13,560258600	Fref±1.356 kHz	-0,020	PASS
30	5,00	2	13,560246700	Fref±1.356 kHz	-0,032	PASS
30	5,00	5	13,560245700	Fref±1.356 kHz	-0,033	PASS
30	5,00	10	13,560247700	Fref±1.356 kHz	-0,031	PASS
20	4,25	0	13,560286700	Fref±1.356 kHz	0,008	PASS
20	4,25	2	13,560276700	Fref±1.356 kHz	-0,002	PASS
20	4,25	5	13,560274700	Fref±1.356 kHz	-0,004	PASS
20	4,25	10	13,560273700	Fref±1.356 kHz	-0,005	PASS
20	5,00	0	13,560297700	Fref±1.356 kHz	0,019	PASS
20	5,00	2	13,560280700	Fref±1.356 kHz	0,002	PASS
20	5,00	5	13,560278700	Fref±1.356 kHz	0,000	PASS
20	5,00	10	13,560278700	Fref	0,000	PASS
20	5,75	0	13,560305700	Fref±1.356 kHz	0,027	PASS
20	5,75	2	13,560282700	Fref±1.356 kHz	0,004	PASS
20	5,75	5	13,560281700	Fref±1.356 kHz	0,003	PASS
20	5,75	10	13,560282700	Fref±1.356 kHz	0,004	PASS
10	5,00	0	13,560331731	Fref±1.356 kHz	0,053	PASS
10	5,00	2	13,560329327	Fref±1.356 kHz	0,051	PASS
10	5,00	5	13,560315705	Fref±1.356 kHz	0,037	PASS
10	5,00	10	13,560321314	Fref±1.356 kHz	0,043	PASS
0	5,00	0	13,560346955	Fref±1.356 kHz	0,068	PASS
0	5,00	2	13,560344551	Fref±1.356 kHz	0,066	PASS
0	5,00	5	13,560346955	Fref±1.356 kHz	0,068	PASS
0	5,00	10	13,560342147	Fref±1.356 kHz	0,063	PASS
-10	5,00	0	13,560345353	Fref±1.356 kHz	0,067	PASS
-10	5,00	2	13,560343750	Fref±1.356 kHz	0,065	PASS
-10	5,00	5	13,560348558	Fref±1.356 kHz	0,070	PASS
-10	5,00	10	13,560350160	Fref±1.356 kHz	0,071	PASS
-20	5,00	0	13,560308936	Fref±1.356 kHz	0,030	PASS
-20	5,00	2	13,560324160	Fref±1.356 kHz	0,045	PASS
-20	5,00	5	13,560323359	Fref±1.356 kHz	0,045	PASS
-20	5,00	10	13,560324962	Fref±1.356 kHz	0,046	PASS



## 5 TEST EQUIPMENT

Manufacturer & Description	Model No.	SIQ No.	Last Calibration	Next Calibration	Used
ETS, Anechoic chamber	RFD-F/A-100	103949	2015-11	2017-11	Х
Rohde & Schwarz, RFI test receiver	ESU8	105187	2015-11	2017-11	Х
Rohde & Schwarz, RFI receiver	ESU26	106897	2016-02	2018-02	1
EMCO, Antenna	3142B	104351	2015-09	2017-09	Χ
EMCO, Antenna	3115	103002	2015-09	2017-09	1
Rohde & Schwarz, Test Probe Antenna	HFH2-Z4	SN:879743/12	N/A	NA	Х
Rohde & Schwarz, Loop Antenna	HFH2-Z2	SN: 879605/15	2015-09	2017-09	Х
Heinrich Deisel, Turn table	DS 420.00	103337	N/A	NA	Χ
ETS, Antenna tower	2175	1	N/A	NA	Χ
ETS, Controller for turn table and antenna tower	2090	1	N/A	NA	Х
Rohde & Schwarz, Artificial main network	ESH 2-Z5	106899	2015-05	2017-05	Х
Rohde & Schwarz, Artificial main network	ENV216	106765	2016-09	2018-09	1
Rohde & Schwarz, Current probe	EZ-17	106862	2016-11	2018-11	1
Schwarzbeck, High voltage probe	TK 9420	106898	2015-05	2017-05	1
Kambič, Temperature chamber	I-190 CK	107298	N/A	NA	Х
Iskra, DC power source	MA 4181	IKM 1790	N/A	NA	Χ
Fluke, Digital Multimeter	179	2839652	2016-11	2018-11	Х
Fluke, Digital Multimeter	179	2839648	2016-11	2018-11	Χ